MATHEMATICS IN INDUSTRY **11**

Editors

Hans-Georg Bock Frank de Hoog Avner Friedman Arvind Gupta Helmut Neunzert William R. Pulleyblank Torgeir Rusten Fadil Santosa Anna-Karin Tornberg

THE EUROPEAN CONSORTIUM FOR MATHEMATICS IN INDUSTRY



SUBSERIES

Managing Editor Vincenzo Capasso

Editors Robert Mattheij Helmut Neunzert Otmar Scherzer G. Ciuprina D. Ioan *Editors*

Scientific Computing in Electrical Engineering

With 231 Figures, 112 in Color, and 33 Tables



Editors Gabriela Ciuprina Daniel Ioan Politehnica University of Bucharest Electrical Engineering Department Spl. Independentei 313 060042, Bucharest, Romania Email: gabriela@lmn.pub.ro daniel@lmn.pub.ro

Library of Congress Control Number: 2007926783

Mathematics Subject Classification (2000): 65-06, 65Lxx, 65Mxx, 65Nxx, 65Yxx, 78-06

ISBN 978-3-540-71979-3 Springer Berlin Heidelberg New York

This work is subject to copyright. All rights are reserved, whether the whole or part of the material is concerned, specifically the rights of translation, reprinting, reuse of illustrations, recitation, broadcasting, reproduction on microfilm or in any other way, and storage in data banks. Duplication of this publication or parts thereof is permitted only under the provisions of the German Copyright Law of September 9, 1965, in its current version, and permission for use must always be obtained from Springer. Violations are liable for prosecution under the German Copyright Law.

Springer is a part of Springer Science+Business Media

springer.com

© Springer-Verlag Berlin Heidelberg 2007

The use of general descriptive names, registered names, trademarks, etc. in this publication does not imply, even in the absence of a specific statement, that such names are exempt from the relevant protective laws and regulations and therefore free for general use.

Typeset by the editors and SPi using a Springer LATEX macro-package Cover design: design & production GmbH, Heidelberg Printed on acid-free paper SPIN: 12049363 46/3142/YL - 5 4 3 2 1 0

Preface

The sixth international conference on Scientific Computing in Electrical Engineering (SCEE) was another event in the SCEE series, aiming to bring together scientists from universities and industry with the goal of intensive discussions about modeling and simulation of electronic circuits and electromagnetic fields. It was held in Sinaia, Romania, from 17^{th} to 22^{nd} September 2006 and it was endorsed by Philips Research Laboratories, Eindhoven (*http://www.philips.nl*), Infineon Technologies from Munich (*http://www.infineon.com*), ST Microelectronics (*http://www.st.com*), Computer Simulation Technology (*http://www.cst.com*), IEEE Romania Section (*http://www.ieee.ro*), Romanian Ministry of Education and Research by the CEEX program (*http://www.mct-excelenta.ro*).

The history of SCEE begun in 1997, as a national German meeting held in Darmstadt and then in Berlin (1998), both under the auspices of the DMV (Deutscher Mathematiker Verein). In 2000, the first truly international workshop was organized in Warnemünde by the University of Rostock, Germany (*http://www.scee-2000.unirostock.de/*). In 2002, the 4th SCEE conference was jointly organized by the Eindhoven University of Technology (TU/e) and Philips Research Laboratories Eindhoven, The Netherlands (*http://www.win.tue.nl/scee2002/*). In 2004, the 5th SCEE conference took place in Capo D'Orlando, Italy, organized by Universita di Catania and Consorzio Catania Ricerche (*http://www.dmi.unict.it/scee2004/*). A SCEE Summer School on Computational methods for microelectronics was organized in 2005 as a follow up of the SCEE04 conference (*http://unict.it/sceeschools*). The 6th conference was organized by "Universitatea Politehnica din Bucuresti (UPB), Centrul de Inginerie Electrica Asistata de Calculator (CIEAC) - Laboratorul de Metode Numerice (LMN)" in Sinaia, Romania (*http://www.scee06.org/*).

As on all previous occasions, the conference was supported both from the industrial sector and academia, thus being guaranteed the relevance of work to practical situations and challenging open problems.

One of the main aims of the SCEE events is to strengthen the interaction between electrical or electronic engineers and the mathematics community. This aim is also

VI Preface

illustrated by the SCEE logo which has some lines that might be interpreted as field lines or wave fronts and part of a bracket which stands for mathematical bracket but also symbolizes the idea of connecting together several communities mathematicians and engineers, university and industry. This logo was designed by Ramona Weyde-Ferch for SCEE 2000.

The conference provided an excellent opportunity to the European Community for project meetings (*www.chameleon-rf.org*, *www.comson.org*) or to discuss new research projects in the EU seventh research program FP7.

The conference topics were: **Computational Electromagnetics** (Modelling and parameter extraction, Discretization and Solution Methods, Applications :Antennas, Microwave, Interconnects and on-chip passive structures), **Circuit Simulation** and Design (Reduced Order Modeling, Numerical Integration Techniques, TCAD/EDA tools and techniques, Applications: Radio Frequency, Power Electronics,Optical Networks), **Coupled Problems** (Field-circuit coupled problems, Multi-physics (coupling, Coupling with electrical, thermal and mechanical problems, Application: Co-Simulation, Electromagnetic Compatibility, Bio-engineering), **Mathematical and Computational Methods** (Inverse Problems, Optimization, Multi-Scale Schemes, Solutions methods for large linear systems, Differential-Algebraic Equations, Grid Computing).

The Program Committee consisted of:

- Prof. A. M. Anile Universita di Catania, Italy
- Dr. A. Bossavit Ecole Superiore delectricite Gif sur Yvette, France
- Assoc. Prof. Dr. G. Ciuprina Univ. Politehnica din Bucuresti, Romania
- Dr. U. Feldmann Infineon Technologies AG, Germany
- Prof. Dr. M. Günther Bergische Universitat Wuppertal, Germany
- Prof. Dr. D. Ioan Univ. Politehnica din Bucuresti, Romania
- Prof. Dr. U. Langer Johannes Kepler Univ., Austria
- Dr. E. J. W. ter Maten Philips Research, The Netherlands
- Prof. Dr. U. van Rienen Univ. Rostock, Germany
- Prof. Dr. W. H. A. Schilders Philips Research, Eindhoven Univ. of Technology, The Netherlands
- Prof. Dr. T. Weiland Technische Univ. Darmstadt, Germany

The Program Committee selected invited speakers from industry and academia for each of the four topics. Thus, SCEE 2006 was honoured by the presence of the following **invited speakers**:

- Prof. Athanasios C. Antoulas, (Rice University Electrical and Computer Engineering Dpt. ECE, Houston, Texas USA): "Approximation of large-scale dynamical systems: An overview and some new results";
- Dr. Janne Roos, (Helsinki University of Technology, Circuit Theory Lab -APLAC
 Finland): "Overview of Circuit-Simulation Activities at TKK CTL";
- Prof. Luis Miguel Silveira, (Technical University of Lisbon (IST), School of Engineering, Department of Electrical and Computer Engineering, INESC-ID, Lisbon Portugal): "Outstanding Challenges in Model Order Reduction";
- Dr. Francois Henrotte, (RWTH Aachen University Institut fur Elektrische Maschinen, Germany): "The energy viewpoint in computational electromagnetics";
- Dr. Irina Munteanu, (CST Germany): "RF & Microwave Simulation with the Finite Integration Technique From component to system design";
- Dr. Herbert De Gersem, (Technical University Darmstadt, Computational Electromagnetics Lab. - TEMF - Germany): "Transient field-circuit coupled models with switching elements for the simulation of electric energy transducers";
- Dr. Andrea Marmiroli, (STMicroelectronics, Italy): "Technology and Device modelling in micro and nanoelectronics: current and future challenges";
- Prof. Barbara Wohlmuth, (Stuttgart University Institut fur Angewandte Analysis und Numerische Simulation IANS - Germany): "Advances in Mathematical and Computational Methods Applied in Electrical Engineering";
- Prof. Piet Hemker, (Centre for Mathematics and Computer Science CWI, Dpt. Modelling, Analysis and Simulation, Amsterdam, Univ. of Amsterdam, Dpt. of Mathematics, The Netherlands): "Space mapping and defect correction for efficient optimization:.

Overall, there were about 100 contributions (40 oral presentations and 60 posters) including the talks of the Invited Speakers. As in previous editions, there were sessions dedicated to short oral introduction of poster, where each contributor was given two minutes to advertise his/her work.

It has always been the policy of these conferences to encourage participants from all countries, and this conference has been remarkably succesfull, there were about 90 participants from 14 countries. This confirmed that SCEE 2006 was a truly international event.

The papers appearing in this book represent a selection of papers presented at the conference. Each paper was carefully referreed by two or three referees chosen by the Program Committee. The Program Committee supervised the reviewing iterative process, aiming to improve the published form of the articles.

VIII Preface

The selected papers have been organized according to the scientific area. Therefore, there are four parts, respectively devoted to Coupled Problems, Circuit Simulation, Electromagnetism and General Mathematical Computational Methods.

We would like to thank the referees of the papers who have spent a lot of time in order to ensure a high quality scientific level of the papers in this book and also to their effort to help us in completing the reviewing process according to the time schedule.

The local organizing committee is greatly indebted to the financial support received from the sponsors and to all the people whose enthusiasm and hard work ensured the success of the conference. Special thanks go to Prof. Mihai Iordache, the Dean of the Electrical Engineering Faculty of the Politehnica University of Bucharest for his constant and precious support. Finally, we would like to thank Ph.D. students Diana Mihalache and Alexandra Stefanescu for the care they have shown in assembling all the information into this book.

Bucharest, March, 2007 Gabriela Ciuprina Daniel Ioan

Contents

Part I Coupled Problems

Comparison of Model Reduction Methods with Applications to Circuit Simulation	
Roxana Ionutiu, Sanda Lefteriu, Athanasios C. Antoulas	3
Transient Field-Circuit Coupled Models with Switching Elements for the Simulation of Electric Energy Transducers <i>Herbert De Gersem, Galina Benderskaya, Thomas Weiland</i>	25
Technology and Device Modeling in Micro and Nano-electronics: Current and Future Challenges <i>Andrea Marmiroli, Gianpietro Carnevale, Andrea Ghetti</i>	41
New Algorithm for the Retrieval of Aerosol's Optical Parameters by LIDAR Data Inversion Camelia Talianu, Doina Nicolae, C. P. Cristescu, Jeni Ciuciu, Anca Nemuc,	
Emil Carstea, Livio Belegante, Mircea Ciobanu	55
A Demonstrator Platform for Coupled Multiscale Simulation Carlo de Falco, Georg Denk, Reinhart Schultz	63
Upon the Interaction between Magnetic Field and Electric Arc in Low Voltage Vacuum Circuit Breakers	
Paula Anghelita	73
Accurate Modeling of Complete Functional RF Blocks: CHAMELEON RF	
H.H.J.M. Janssen, J. Niehof and W.H.A. Schilders	81
Finite Element Analysis of Generation and Detection of Lamb Waves Using Piezoelectric Transducers	
Sorohan St., Constantin N., Anghel V., Gavan M	89

Х	Contents

Optimization of a Switching Strategy for a Synchronous Motor Fed by a Current Inverter Using Finite Element Analysis Vasile Manoliu
Finite Volume Method Applied to Symmetrical Structures in Coupled Problems Ioana - Gabriela Sîrbu
Scattering Matrix Analysis of Cascaded Periodic Surfaces Adriana Savin, Raimond Grimberg, Rozina Steigmann
Part II Circuit Simulation and Design
Overview of Circuit-Simulation Activities at TKK CTL Janne Roos 127
Outstanding Issues in Model Order Reduction João M. S. Silva, Jorge Fernández Villena, Paulo Flores, L. Miguel Silveira 139
Positive Real Balancing for Nonlinear Systems Tudor C. Ionescu, Jacquelien M. A. Scherpen153
Efficient Initialization of Artificial Neural Network Weights for Electrical Component Models <i>Tuomo Kujanpää and Janne Roos</i> 161
Trajectory Piecewise Linear Approach for Nonlinear Differential- Algebraic Equations in circuit simulation <i>T. Voβ, R. Pulch, E.J.W. ter Maten, A. El Guennouni</i>
Model Order Reduction of Large Scale ODE Systems: MOR for ANSYS versus ROM Workbench A.J. Vollebregt, T. Bechtold, A. Verhoeven, E.J.W. ter Maten
Adjoint Transient Sensitivity Analysis in Circuit SimulationZ. Ilievski, H. Xu, A. Verhoeven, E.J.W. ter Maten, W.H.A. Schildersand R.M.M. Mattheij183
Index Reduction by Element-Replacement for Electrical Circuits Simone Bächle and Falk Ebert 191
Application of 2D Nonuniform Fast Fourier Transforms Techniqueto Analysis of Shielded Microstrip CircuitsRaimond Grimberg, Adriana Savin, Sorin Leitoiu199
A Filter Design Framework with Multicriteria Optimization Based on a Genetic Algorithm Neag Marius, Marina Topa, Liviu Nedelea, Lelia Festila, Vasile Topa

Contents	XI
Thermal Network Method in the Design of Power Equipment C. Gramsch, A. Blaszczyk, H. Löbl, S. Grossmann	213
Hierarchical Mixed Multirating in Circuit Simulation Michael Striebel and Michael Günther	221
Automatic Partitioning for Multirate Methods A. Verhoeven, B. Tasić, T.G.J. Beelen, E.J.W. ter Maten, R.M.M. Mattheij	229
Simulation of Quasiperiodic Signals via Warped MPDAEs Using Houben's Approach Julia Greb, Roland Pulch	237
Part III Computational Electromagnetics	
RF & Microwave Simulation with the Finite Integration Technique – From Component to System Design <i>I. Munteanu, T. Weiland</i>	247
The Energy Viewpoint in Computational Electromagnetics Francois Henrotte, Kay Hameyer	261
Newton and Approximate Newton Methods in Combination with the Orthogonal Finite Integration Technique H. De Gersem, I. Munteanu, T. Weiland	275
Transient Simulation of a Linear Actuator Discretized by the Finite Integration Technique <i>Mariana Funieru, Herbert De Gersem, Thomas Weiland</i>	
Reduced Order Electromagnetic Models for On-Chip Passives Based on Dual Finite Integrals Technique <i>Gabriela Ciuprina, Daniel Ioan, Diana Mihalache</i>	287
Techniques to Reduce the Equivalent Parallel Capacitance for EMI Filters Integration <i>Adina Racasan, Calin Munteanu, Vasile Topa, Claudia Racasan</i>	295
Buffered Block Forward Backward (BBFB) Method Applied to EM Wave Scattering from Homogeneous Dielectric Bodies Conor Brennan, Diana Bogusevschi	301
Symmetric Coupling of the Finite-Element and the Boundary-Element Method for Electro-Quasistatic Field Simulations T. Steinmetz, N. Gödel, G. Wimmer, M. Clemens, S. Kurz, M. Bebendorf, S. Rjasanow	309

XII Contents

Computational Errors in Hysteresis Preisach Modelling Valentin Ionita, Lucian Petrescu		
Part IV Mathematical and Computational Methods		
Manifold Mapping for Multilevel Optimization Pieter W. Hemker, David Echeverría		
Software Package for Multi-Objective Optimal Design of Electromagnetic Devices Calin Munteanu, Gheorghe Mates, Vasile Topa		
Optimal Design of Monolithic ESBT ® Device carried out by Multiobjective Optimization. <i>Salvatore Spinella, Vincenzo Enea, Daniele Kroell, Michele Messina, Cesare</i>		
Ronsisvalle		
On Fast Optimal Control for Energy-Transport-based Semiconductor Design C. R. Drago		
Extended Hydrodynamical Models for Charge Transport in Si Roberto Beneduci, Giovanni Mascali, Vittorio Romano		
On the Implementation of a Delaunay-based 3-dimensional Mesh Generator K.J. van der Kolk, N.P. van der Meiis		
Coupled FETI/BETI Solvers for Nonlinear Potential Problems in (Un)Bounded Domains Ulrich Langer, Clemens Pechstein		
A Hierarchical Preconditioner within Edge Based BE-FE Coupling in Electromagnetism K. Straube, I. Ibragimov, V. Rischmüller, S. Rjasanow		
Solution of Band Linear Systems in Model Reduction for VSLI Circuits Alfredo Remón, Enrique S. Quintana-Ortí, Gregorio Quintana-Ortí		
MOESP Algorithm for Converting One-dimensional Maxwell Equation into a Linear System E. F. Yetkin, H. Dağ, W. H. A. Schilders		
Adaptive Methods for Transient Noise Analysis Thorsten Sickenberger, Renate Winkler 403		
Efficient Execution of Loosely Coupled Tasks in Grid Platforms <i>Felicia Ionescu, Stefan Diaconescu, Alexandru Gherega, Gabriel Dimitriu</i> 411		

	Contents	XIII
Colour Figures		417
Index		463

List of Contributors

V. Anghel Politehnica University of Bucharest Spl. Independentei 313 060042, Bucharest, Romania.

Paula Anghelita Research and Development Institute for Electrical Industry apel2@icpe.ro.

Athanasios C. Antoulas Rice University Department of Electrical and Computer Engineering Houston, TX, USA aca@rice.edu.

Simone Bächle Technical University of Berlin Institute of Mathematics MA 4-5 Straße des 17. Juni 136 10623 Berlin, Germany baechle@math.tu-berlin.de.

M. Bebendorf University of Leipzig Mathematical Institute D-04109 Leipzig, Germany bebendorf@math.uni-leipzig.de. T. Bechtold Philips Semiconductors - NXP Eindhoven tamara.bechtold@nxp.com.

T.G.J. Beelen DMS, NXP Semiconductors B.V. High Tech Campus 48 5656 AE Eindhoven, The Netherlands bratislav.tasic@philips.com.

Livio Belegante National Institute of R&D for Optoelectronic camelia@inoe.inoe.ro.

Galina Benderskaya Technische Universität Darmstadt Schloßgartenstraße 8, D-64289 Darmstadt, Germany DeGersem@temf.tu-darmstadt.de.

Roberto Beneduci University of Calabria and INFN-Gruppo c.Cosenza Italy rbeneduci@unical.it.

A. Blaszczyk ABB Corporate Research 5405 Baden-Daettwil, Switzerland Andreas.Blaszczyk@ch.abb.com.

XVI List of Contributors

Diana Bogusevschi Dublin City University diana@eeng.dcu.ie.

Conor Brennan Dublin City University brennanc@eeng.dcu.ie.

Gianpietro Carnevale STMicroelectronics 20041 Agrate Brianza, Italy.

Emil Carstea National Institute of R&D for Optoelectronic.

Mircea Ciobanu National Institute of R&D for Optoelectronic.

Jeni Ciuciu National Institute of R&D for Optoelectronic .

Gabriela Ciuprina

Politehnica University of Bucharest Electrical Engineering Department Spl. Independentei 313 060042 Bucharest, Romania lmn@lmn.pub.ro.

M. Clemens

Helmut-Schmidt-University Department of Electrical Engineering D-22043 Hamburg, Germany.

N. Constantin Politehnica University of Bucharest Spl. Independentei 313 060042 Bucharest, Romania.

C. P. Cristescu Politehnica University of Bucharest Spl. Independentei 313 060042 Bucharest, Romania cpcris@physics.pub.ro.

H. Daĝ

Isk University Information Technologies Department Istanbul, Turkey dag@isikun.edu.tr.

Carlo de Falco Bergische Universität Wuppertal and Qimonda AG, München defalco@math.uni-wuppertal.de.

Herbert De Gersem

Technische Universität Darmstadt Schloßgartenstraße 8 D-64289 Darmstadt, Germany DeGersem@temf.tu-darmstadt.de.

Georg Denk Qimonda AG, München.

Stefan Diaconescu

Politehnica University of Bucharest Spl. Independentei 313 060042, Romania.

Gabriel Dimitriu

Politehnica University of Bucharest Spl. Independentei 313 060042, Romania.

C. R. Drago

Università di Catania Dipartimento di Matematica e Informatica Viale A. Doria 6 I-95125 - Catania drago@dmi.unict.it.

Gheorghe Dumitrescu

Research and Development Institute for Electrical Industry apel2@icpe.ro.

Falk Ebert

Technical University of Berlin Institute of Mathematics MA 4-5 Straße des 17. Juni 136 10623 Berlin, Germany ebert@math.tu-berlin.de.

List of Contributors XVII

David Echeverría Centrum voor Wiskunde en Informatica Kruislaan 413, NL 1098 SJ Amsterdam The Netherlands D.Echeverria@cwi.nl.

A. El Guennouni Magma Design Automation Eindhoven, The Netherlands .

Vincenzo Enea STMicroelectronics Stradale Primosole 50 I-95121 Catania, Italy.

Jorge Fernández Villena INESC ID / Instituto Superior Técnico Technical University of Lisbon Rua Alves Redol, 9 1000-029 Lisboa, Portugal jorge@algos.inesc-id.pt.

Lelia Festila Technical University of Cluj-Napoca Str Ctin Dacovicuiu,nr 15 400020 Cluj-Napoca.

Paulo Flores INESC ID / Instituto Superior Técnico Technical University of Lisbon Rua Alves Redol, 9 1000-029 Lisboa, Portugal.

Mariana Funieru Technical Universität Darmstadt Institut für Theorie Elektromagnetische Felder Schloßgartenstraße 8 D-64289 Darmstadt, Germany

funieru@temf.tudarmstadt.de.

N. Gödel

Helmut-Schmidt-University Department of Electrical Engineering D-22043 Hamburg, Germany. Michael Günther Bergische Universität Wuppertal Departement of Mathematics D-42097 Wuppertal, Germany guenther@math.uni-wuppertal.de.

M. Gavan Politehnica University of Bucharest Spl. Independentei 313 060042, Bucharest, Romania.

Alexandru Gherega

University Politehnica Bucharest Spl. Independentei 313 060042, Bucharest, Romania.

Andrea Ghetti

STMicroelectronics 20041 Agrate Brianza, Italy.

C. Gramsch

hagenuk KMT GmbH Rderaue 41 01471 Radeburg, Germany Gramsch.C@sebakmt.com.

J. Greb

Bergische Universität Wuppertal Fachbereich Mathematik und Naturwissenschaften Gaußstr. 20 D-42119 Wuppertal, Germany.

Raimond Grimberg

National Institute of R&D for Technical Physics 47 D. Mangeron Blv., Iasi 700050, Romania grimberg@phys-iasi.ro.

S. Grossmann

Technical University Dresden Institute of Electrical Power Systems and High Voltage Engineering 01062 Dresden, Germany Grossmann@ieeh.et.tu-dresden.de.

XVIII List of Contributors

Kay Hameyer Institute of Electrical Machines RWTH Aachen University Schinkelstrae 4 D-52056 Aachen, Germany .

Pieter W. Hemker Centrum voor Wiskunde en Informatica Kruislaan 413, NL 1098 SJ Amsterdam The Netherlands P.W.Hemker@cwi.nl.

Francois Henrotte RWTH Aachen University Institute of Electrical Machines Schinkelstrae 4 D-52056 Aachen, Germany fh@iem.rwth-aachen.de.

I. Ibragimov University of Saarland PF 15 11 50, 66041 Saarbrücken, Germany ilgis@num.uni-sb.de.

Z. Ilievski Technische Universiteit Eindhoven Z.Ilievski@tue.nl.

Daniel Ioan

Politehnica University of Bucharest Electrical Engineering Department Spl. Independentei 313 060042 Bucharest, Romania lmn@lmn.pub.ro.

Felicia Ionescu Politehnica University of Bucharest Spl. Independentei 313 060042 Bucharest, Romania fionescu@tech.pub.ro.

Tudor C. Ionescu Rijksuniversiteit Groningen t.c.ionescu@rug.nl.

Valentin Ionita

Politehnica University of Bucharest Electrical Eng. Dept. Spl. Independentei 313 060042 Bucharest, Romania vali@mag.pub.ro.

Roxana Ionutiu

Rice University Department of Electrical and Computer Engineering Houston, TX, USA rlonutiu@rice.edu.

H.H.J.M. Janssen

NXP Semiconductors Research High Tech Campus 5 5656 AE, Eindhoven, The Netherlands rick.janssen@nxp.com.

Daniele Kroell

STMicroelectronics Stradale Primosole 50 I-95121 Catania, Italy.

Tuomo Kujanpää

Helsinki University of Technology Circuit Theory Laboratory P.O.Box 3000 FI-02015 TKK,Finland tuomo.kujanpaa@tkk.fi.

S. Kurz

Helmut-Schmidt-University Department of Electrical Engineering D-22043 Hamburg, Germany .

Ulrich Langer

Johannes Kepler University Institute of Computational Mathematics Altenberger Str. 69 4040 Linz, Austria ulanger@numa.uni-linz.ac.at.

List of Contributors XIX

Sanda Lefteriu

Rice University Department of Electrical and Computer Engineering Houston, TX, USA slefteri@rice.edu.

Sorin Leitoiu National Institute of R&D for Technical Physics 47 D. Mangeron Blv., Iasi 700050, Romania .

H. Löbl

Technical University Dresden Institute of Electrical Power Systems and High Voltage Engineering 01062 Dresden, Germany Loebl@ieeh.et.tudresden.de.

Vasile Manoliu

Politehnica University of Bucharest Electrical Engineering Faculty Spl. Independentei 313 060042, Bucharest, Romania vasilem@amotion.pub.ro.

Andrea Marmiroli

STMicroelectronics 20041 Agrate Brianza, Italy andrea.marmiroli@st.com.

Giovanni Mascali

University of Calabria and INFN-Gruppo c.Cosenza Italy g.mascali@unical.it.

Gheorghe Mates

Technical University of Cluj-Napoca Department of Electrotechnics C. Daicoviciu 15 400020 Cluj-Napoca, Romania. **R.M.M. Mattheij** Technische Universiteit Eindhoven Den Dolech 2, 5600 MB The Netherlands .

Michele Messina

STMicroelectronics Stradale Primosole 50 I-95121 Catania, Italy michele.messina@st.com.

Diana Mihalache

Politehnica University of Bucharest Electrical Engineering Department Spl. Independentei 313 060042 Bucharest, Romania lmn@lmn.pub.ro.

Calin Munteanu

Technical University of Cluj-Napoca Department of Electrotechnics C. Daicoviciu 15 400020 Cluj-Napoca, Romania Calin.Munteanu@et.utcluj.ro.

I. Munteanu

Computer Simulation Technology, Bad Nauheimer Straße 19 D-64289 Darmstadt, Germany munteanu@cst.com.

Neag Marius

Technical University of Cluj-Napoca Str Ctin Dacovicuiu,nr 15 400020 Cluj-Napoca, Romania Marius.Neag@bel.utcluj.ro.

Liviu Nedelea

Technical University of Cluj-Napoca Str Ctin Dacovicuiu,nr 15 400020 Cluj-Napoca, Romania.

Anca Nemuc

National Institute of R&D for Optoelectronic .

XX List of Contributors

Doina Nicolae National Institute of R&D for Optoelectronic .

J. Niehof NXP Semiconductors Research High Tech Campus 5 5656 AE, Eindhoven The Netherlands jan.niehof@nxp.com.

Constantin Nitu Politehnica University of Bucharest Slp. Independentei 313, 060042 Bucharest, Romania .

Smaranda Nitu Politehnica University of Bucharest Slp. Independentei 313, 060042 Bucharest, Romania snitu@apel.apar.pub.ro.

Clemens Pechstein

Johannes Kepler University Special Research Program SFB F013 Altenberger Str. 69 4040 Linz, Austria clemens.pechstein@numa.unilinz.ac.at.

Lucian Petrescu Politehnica University of Bucharest Electrical Eng. Dept. Slp. Independentei 313, 060042 Bucharest, Romania .

Roland Pulch Bergische Universität Wuppertal Fachbereich Mathematik und Naturwissenschaften Gaußstr. 20 D-42119 Wuppertal, Germany pulch@math.uniwuppertal.de. Enrique S. Quintana-Ortí

Universidad Jaume I Depto. de Ingeniería y Ciencia de Computadores 12.071–Castellón, Spain quintana@icc.uji.es.

Gregorio Quintana-Ortí

Universidad Jaume I Depto. de Ingeniería y Ciencia de Computadores 12.071–Castellón, Spain gquintan@icc.uji.es.

Adina Racasan

Technical University of Cluj-Napoca Department of Electrotechnics C. Daicoviciu 15 400020 Cluj-Napoca, Romania Adina.Racasan@et.utcluj.ro.

Claudia Racasan

Technical University of Cluj-Napoca Department of Electrotechnics C. Daicoviciu 15 400020 Cluj-Napoca, Romania.

Alfredo Remón

Universidad Jaume I Depto. de Ingeniería y Ciencia de Computadores 12.071–Castellón, Spain remon@icc.uji.es.

V. Rischmüller

Robert Bosch GmbH PF 10 60 50 70049 Stuttgart, Germany volker.rischmueller@de.bosch.com.

S. Rjasanow University of Saarland PF 15 11 50

66041 Saarbrücken, Germany rjasanow@num.uni-sb.de.

Vittorio Romano University of Catania romano@dmi.unict.it.

List of Contributors XXI

Cesare Ronsisvalle STMicroelectronics Stradale Primosole 50 I-95121 Catania, Italy.

Janne Roos Helsinki University of Technology Circuit Theory Laboratory P.O.Box 3000 FI-02015 TKK, Finland janne@ct.tkk.fi.

Ioana - Gabriela Sîrbu University of Craiova Electrical Engineering Faculty Decebal Blv. No. 107 200440-Craiova, Romania osirbu@elth.ucv.ro.

Adriana Savin National Institute of R&D for Technical Physics 47 D.Mangeron Blvd 700050 Iasi, Romania.

Jacquelien M. A. Scherpen Rijksuniversiteit Groningen j.m.a.scherpen@rug.nl.

W. H. A. Schilders NXP Semiconductors Research High Tech Campus 5 5656 AE, Eindhoven The Netherlands wil.schilders@nxp.com.

Reinhart Schultz Qimonda AG, München.

Thorsten Sickenberger Humboldt-Universität zu Berlin Institut für Mathematik 10099 Berlin sickenbergermath.huberlin.de. João M. S. Silva INESC ID / Instituto Superior Técnico Technical University of Lisbon Rua Alves Redol, 9 1000-029 Lisboa, Portugal jmss@algos.inesc-id.pt.

L. Miguel Silveira INESC ID / Instituto Superior Técnico Technical University of Lisbon Rua Alves Redol, 9 1000-029 Lisboa, Portugal lms@algos.inesc-id.pt.

Stefan Sorohan Politehnica University of Bucharest Spl. Independentei 313 060042, Bucharest, Romania sorohan@form.resist.pub.ro.

Salvatore Spinella Consorzio Catania Ricerche Via A. Sangiuliano 262 I95124 Catania, Italy spins@unical.it.

T. Steinmetz Helmut-Schmidt-University Department of Electrical Engineering D-22043 Hamburg, Germany t.steinmetz@hsu-hh.de.

K. Straube Robert Bosch GmbH PF 10 60 50 70049 Stuttgart, Germany katharina.straube@de.bosch.com.

Michael Striebel Infineon Technologies Austria AG Siemensstr. 2 A-9500 Villach, Austria michael.striebel2@infineon.com.

Camelia Talianu National Institute of R&D for Optoelectronic camelia@inoe.inoe.ro.

XXII List of Contributors

B. Tasić DMS, NXP Semiconductors B.V High Tech Campus 48 5656 AE Eindhoven The Netherlands bratislav.tasic@philips.co.

E.J.W. ter Maten Philips Semiconductors High Tech Campus 48 5656 AE Eindhoven The Netherlands jan.ter.maten@philips.com.

Marina Topa Technical University of Cluj-Napoca Str Ctin Dacovicuiu,nr 15 400020 Cluj-Napoca .

Vasile Topa Technical University of Cluj-Napoca Str Ctin Dacovicuiu,nr 15 400020 Cluj-Napoca .

K.J. van der Kolk Delft University of Technology EEMCS, Circuits and Systems Group Mekelweg 4 NL-2628 CD Delft keesjan@cas.et.tudelft.nl.

N.P. van der Meijs Delft University of Technology EEMCS, Circuits and Systems Group Mekelweg 4 NL-2628 CD Delft nick@cas.et.tudelft.nl.

A. Verhoeven Technische Universiteit Eindhoven Den Dolech 2 5600 MB, The Netherlands averhoev@win.tue.nl.

Т. Уов

University of Groningen Faculty of Mathematics and Natural Sciences Nijenborgh 4 9747 AG Groningen, The Netherlands t.voss@rug.nl.

A.J. Vollebregt Bergische Universität Wuppertal.

Thomas Weiland

Technical Universität Darmstadt Institut für Theorie Elektromagnetische Felder Schloßgartenstraße 8 D-64289 Darmstadt, Germany thomas.weiland@temf.tudarmstadt.de.

G. Wimmer Helmut-Schmidt-University Department of Electrical Engineering D-22043 Hamburg, Germany.

Renate Winkler Humboldt-Universität zu Berlin Institut fürMathematik 10099 Berlin winkler@math.hu-berlin.de.

H. Xu Technische Universiteit Eindhoven .

E. F. Yetkin Istanbul Technical University Informatics Institute Istanbul, Turkey fatih@be.itu.edu.tr.

Part I

Coupled Problems

Comparison of Model Reduction Methods with Applications to Circuit Simulation*

Roxana Ionutiu, Sanda Lefteriu, and Athanasios C. Antoulas

Department of Electrical and Computer Engineering, Rice University, Houston, TX, USA rlonutiu@rice.edu, slefteri@rice.edu, aca@rice.edu

Summary. We compare different model reduction methods applied to the dynamical system of a coupled transmission line: balanced truncation (BT), truncation by balancing one gramian (or PMTBR - poor man's truncated balanced reduction), positive real balanced truncation (PRBT) and its Hamiltonian implementation (PRBT-Ham), PRIMA, spectral zero method (SZM) and its Hamiltonian implementation (SZM-Ham), and finally, optimal \mathcal{H}_2 . Their performance is analyzed in terms of several criteria such as: preservation of controllability, observability, stability and passivity, relative \mathcal{H}_2 and \mathcal{H}_∞ norms, and the computational cost involved.

1 Introduction

This paper presents different reduction methods together with results obtained by applying each method on a dynamical system given by a coupled transmission line. In Sect. 2, a modified nodal analysis (MNA)-similar representation of the system is derived. The model reduction methods are grouped in two main categories, *gramian based* and *Krylov based*, discussed in sections 3 and 4 respectively. Sect. 3 outlines the theory behind gramian based reduction methods: BT, PMTBR and PRBT. Krylov based reduction methods in terms of: preservation of some important properties like controllability, observability, stability and passivity, the relative \mathcal{H}_2 and \mathcal{H}_{∞} norms and in terms of the computational cost. In Sect. 6, error systems resulting from different methods are compared. This allows us to identify frequency ranges where one particular method approximates the original system more accurately. Sect. 7 presents additional results obtained with the optimal \mathcal{H}_2 method. Finally, Sect. 8 summarizes our analysis and motivates further research.

2 State-space representation

The model reduction problem of transmission lines has been studied extensively, see for instance [8]. Our system consists of two transmission lines with inductive

^{*} This work was supported in part by the NSF through Grants CCR-0306503, ACI-0325081, and CCF-0634902. Invited Paper at SCEE-2006

Roxana Ionutiu, Sanda Lefteriu, and Athanasios C. Antoulas

4



coupling as shown in Fig. 1. Each section consists of an inductor and its associated resistor, in series with a capacitor and its associated resistor. The first section has no inductor. All capacitor values C_i are equal. The same holds for the inductors L_i , the coupling inductors M_{ij} , the resistors associated with the capacitors R_{C_i} , the resistors associated with the inductors R_{L_i} and the input resistors, R_1 and R_2 .

To simulate this circuit, the *state-space representation* of the system needs to be derived. Choosing the state variables as the currents through the inductors and the voltages across the capacitors, we obtain a system of order n = 4N - 2, where N is the number of sections of the circuit. The state-space representation in *modified nodal analysis (MNA)*-similar form is the following:

where $\mathbb{C} \in \mathbb{R}^{n \times n}$, $\mathbf{G} \in \mathbb{R}^{n \times n}$, $\mathbf{B} \in \mathbb{R}^{n \times 2}$, $\mathbf{L} \in \mathbb{R}^{2 \times n}$, $\mathbf{D} \in \mathbb{R}^{2 \times 2}$ and $\mathbf{x}(t) \in \mathbb{R}^{n}$, $\mathbf{u}(t) \in \mathbb{R}^{2}$, $\mathbf{y}(t) \in \mathbb{R}^{2}$.

The problem will be studied under the following simplifying assumptions:

- the equations are in an MNA-similar form so that the resulting C matrix in (1) is nonsingular and positive definite (this means that all variables are state variables and none is redundant). In general, C resulting from circuit simulation is singular, due to additionally generated variables at the nodes between L_i and R_{L_i}.
- (2) The transmission line has one input and one output, that is $u_2 = 0$ and only y_1 is observed, so that $\mathbf{u} = u_1$ and $\mathbf{y} = y_1$.

These assumptions are made to ease certain technical issues and allow a comparison of all reduction methods enumerated above; for instance, the optimal \mathcal{H}_2 method is currently available for single-input-single-output (SISO) systems only. None of these assumptions is essential for the validity of the results presented. Similar results for a system with MNA equations (where \mathbb{C} is singular), using in part results from [5], will be reported in a future analysis.

For simplicity we will show the form of the equations by deriving them for N = 3 sections, namely for a circuit with 6 capacitors and 4 inductors, resulting in 10 states. In particular, the elements of the first line, from left to right will be

 $R_1, \ C_1, \ R_{C_1}; \quad L_1, \ R_{L_1}, \ C_2, \ R_{C_2}; \quad L_2, \ R_{L_2}, \ C_3, \ R_{C_3},$ and those of the second line from left to right

 $R_2,\ C_4,\ R_{C_4};\ \ L_3,\ R_{L_3},\ C_5,\ R_{C_5};\ \ L_4,\ R_{L_4},\ C_6,\ R_{C_6}.$ The state variables are:

 $\mathbf{x}_{C_1}, \mathbf{x}_{L_1}, \mathbf{x}_{C_2}, \mathbf{x}_{L_2}, \mathbf{x}_{C_3}, \mathbf{x}_{C_4}, \mathbf{x}_{L_3}, \mathbf{x}_{C_5}, \mathbf{x}_{L_4}, \mathbf{x}_{C_6},$ and the state is chosen as:

$$\mathbf{x} = egin{pmatrix} \mathbf{x}_C \ \mathbf{x}_L \end{pmatrix}, \ \ \mathbf{x}_C = egin{pmatrix} \mathbf{x}_{C_1} \ \mathbf{x}_{C_2} \ \mathbf{x}_{C_3} \ \mathbf{x}_{C_4} \ \mathbf{x}_{C_5} \ \mathbf{x}_{C_6} \end{pmatrix}, \ \ \ \mathbf{x}_L = egin{pmatrix} \mathbf{x}_{L_1} \ \mathbf{x}_{L_3} \ \mathbf{x}_{L_2} \ \mathbf{x}_{L_4} \end{pmatrix}.$$

The associated system matrices are²:

$$\begin{split} & \tilde{\mathbb{C}} = \begin{pmatrix} \tilde{\mathbb{C}} & 0\\ 0 & \tilde{\mathbb{L}} \end{pmatrix}, \ \mathbf{G} = \begin{pmatrix} -\mathbf{R}_{C} & \tilde{\mathbb{E}}\\ -\tilde{\mathbb{E}}^{*} & -\mathbf{R}_{L} \end{pmatrix}, \ \mathbf{B} = \begin{pmatrix} \frac{1}{R_{1}} & 0 & 0 & 0 & 0 & 0 & 0 & 0 \end{pmatrix}^{*}, \\ & \mathbf{L} = -\mathbf{B}^{*} \text{ and } \mathbf{D} = \frac{1}{R_{1}}, \text{ where:} \\ & \tilde{\mathbb{C}} = \operatorname{diag}(C_{1}, C_{2}, C_{3}, C_{4}, C_{5}, C_{6}), \ \tilde{\mathbb{L}} = \begin{pmatrix} L_{1} & M_{13} & \\ M_{13} & L_{3} & \\ & L_{2} & M_{24} \\ & M_{24} & L_{4} \end{pmatrix} \text{ and} \\ & & L_{2} & M_{24} \\ & & M_{24} & L_{4} \end{pmatrix} \\ & \tilde{\mathbb{E}} = \begin{pmatrix} -1 & 0 & 0 & 0 \\ 1 & 0 & -1 & 0 \\ 0 & 0 & 1 & 0 \\ 0 & -1 & 0 & 0 \\ 0 & 1 & 0 & -1 \\ 0 & 0 & 0 & 1 \end{pmatrix}, \ \mathbf{R}_{C} = \operatorname{diag}(\frac{1}{R_{1}} + \frac{1}{R_{C_{1}}}, \frac{1}{R_{C_{2}}}, \frac{1}{R_{C_{3}}}, \frac{1}{R_{2}} + \frac{1}{R_{C_{4}}}, \frac{1}{R_{C_{5}}}, \frac{1}{R_{C_{6}}}) \\ & \mathbf{R}_{L} = \operatorname{diag}(R_{L_{1}}, R_{L_{3}}, R_{L_{2}}, R_{L_{4}}). \end{split}$$

The values of the elements used in the simulation are as follows: the input resistors are $R_1 = R_2 = 10\Omega$, the capacitors are $C_i = 5.4 \cdot 10^{-12}F$ and the associated resistors $R_{C_i} = 10^3\Omega$, (i = 1, ..., 6), the inductors are $L_i = 0.25 \cdot 10^{-9}H$, (i = 1, ..., 4), the mutual inductors are $M_{ij} = 0.2L_i$ (i = 1, 2, j = 3, 4) of that value. The associated resistors are zero $R_{L_i} = 0$, (i = 1, ..., 4).

3 Gramian based methods

Gramian based methods involve diagonalization of gramians by congruence. These can either be the positive definite solutions to the Lyapunov equations (called *controllability* and *observability gramians*) or the positive definite solutions to algebraic Ricccati equations (called *positive real controllability* and *observability gramians*). The methods that we discuss are balanced truncation (BT) in Sect. 3.1 which

² For a matrix **M**, **M**^{*} denotes transposition followed by complex conjugation if the matrix is complex.

performs simultaneous diagonalization of the controllability and the observability gramians, an equivalent of poor man's truncated balanced reduction (PMTBR) in Sect. 3.2 in which only one of the gramians is diagonalized and positive real balanced truncation (PRBT) in Sect. 3.3 in which positive definite solutions to the algebraic Ricatti equations are simultaneously diagonalized.

3.1 Balanced truncation (BT)

The idea behind balanced truncation is to simultaneously diagonalize the two infinite gramians, \mathcal{P} and \mathcal{Q} [1]. These are the solutions to the controllability and observability *Lyapunov equations* respectively, which are associated with the state space formuation (1). The mathematical model of the system may come in two representations: standard state-space and MNA-similar representation (or invertible descriptor form), respectively. We describe the application of model reduction methods for both cases of models.

Standard state-space representation

The standard state-space representation $(\mathbf{A}_{ss}, \mathbf{B}_{ss}, \mathbf{C}_{ss}, \mathbf{D}_{ss})$ is obtained from (1) by inverting the \mathbb{C} matrix.

$$\mathbf{A}_{ss} = \mathbb{C}^{-1}\mathbf{G}, \mathbf{B}_{ss} = \mathbb{C}^{-1}\mathbf{B}, \mathbf{C}_{ss} = -\mathbf{B}^*, \mathbf{D}_{ss} = \mathbf{D}$$

The controllability and observability gramians are given by the symmetric positive definite solutions to the controllability and observability Lyapunov equations:

$$\mathbf{A}_{ss}\mathcal{P} + \mathcal{P}\mathbf{A}_{ss}^* + \mathbf{B}_{ss}\mathbf{B}_{ss}^* = 0 \tag{2}$$

$$\mathbf{A}_{ss}^* \mathcal{Q} + \mathcal{Q} \mathbf{A}_{ss} + \mathbf{C}_{ss}^* \mathbf{C}_{ss} = 0$$
(3)

BT is performed in two steps. First, the balancing projection is computed (both gramians become equal and diagonal, with the Hankel singular values (HSVs) on the diagonal). Second, the states which are equally difficult to reach and to observe are truncated. This amounts to eliminating the states corresponding to the HSVs which are below a certain tolerance. Setting a tolerance for the reduced system a priori defines the number of states to be kept. The procedure is the following.

- 1. Compute the Cholesky factors of $\mathcal{P} = \mathbf{U}\mathbf{U}^*$ and $\mathcal{Q} = \mathbf{L}\mathbf{L}^*$
- 2. Compute the singular value decomposition of the product $\mathbf{U}^*\mathbf{L}$

$$\mathbf{U}^*\mathbf{L} = \mathbf{ZSY}^*$$

(4)

The diagonal elements: $\mathbf{S} = \operatorname{diag}(\sigma_1, \ldots, \sigma_n), \sigma_1 \geq \sigma_2 \geq \ldots \geq \sigma_n$, where $\sigma_i = \sqrt{\lambda_i(\mathcal{PQ})}$ are the *Hankel singular values* of the system. Choosing only the first k singular values and the first k columns of \mathbf{Z} and \mathbf{Y} gives the reduced system of order k after applying the projection $\mathbf{\Pi}$

- 3. $\Pi = \mathbf{V}\mathbf{W}^*$ where $\mathbf{V} = \mathbf{U}\mathbf{Z}_k\mathbf{S}_k^{-\frac{1}{2}}, \ \mathbf{V} \in \mathbb{R}^{n \times k}, \ \mathbf{W} = \mathbf{L}\mathbf{Y}_k\mathbf{S}_k^{-\frac{1}{2}}, \ \mathbf{W} \in \mathbb{R}^{n \times k}$
- 4. Compute the representation of the reduced system:

$$\mathbf{A}_{ss} = \mathbf{W}^* \mathbf{A}_{ss} \mathbf{V}, \mathbf{B}_{ss} = \mathbf{W}^* \mathbf{B}_{ss}, \mathbf{C}_{ss} = \mathbf{C}_{ss} \mathbf{V}, \mathbf{D}_{ss} = \mathbf{D}_{ss}$$

The corresponding diagonalized controllability and observability gramians are given by $\tilde{\mathcal{P}} = \mathbf{W}^* \mathcal{P} \mathbf{W} = \mathbf{S}_k$, $\tilde{\mathcal{Q}} = \mathbf{V}^* \mathcal{Q} \mathbf{V} = \mathbf{S}_k$ where \mathbf{S}_k is the matrix containing the largest k HSV's on the diagonal.

Descriptor form representation

The MNA-similar representation is precisely (1). For simplicity, we rename the matrices in (1) to match the standard descriptor system representation:³

$$\mathbf{E}_{ds} = \mathbb{C}, \mathbf{A}_{ds} = \mathbf{G}, \mathbf{B}_{ds} = \mathbf{B}, \mathbf{C}_{ds} = \mathbf{L}, \mathbf{D}_{ds} = \mathbf{D}$$

The gramians are now the solutions to the following Lyapunov equations:

$$\mathbf{A}_{ds}\mathcal{P}\mathbf{E}_{ds}^* + \mathbf{E}_{ds}\mathcal{P}\mathbf{A}_{ds}^* + \mathbf{B}_{ds}\mathbf{B}_{ds}^* = 0$$
⁽⁵⁾

$$\mathbf{A}_{ds}^* \hat{\mathcal{Q}} \mathbf{E}_{ds} + \mathbf{E}_{ds}^* \hat{\mathcal{Q}} \mathbf{A}_{ds} + \mathbf{C}_{ds}^* \mathbf{C}_{ds} = 0, \tag{6}$$

where \mathcal{P} in (5) is precisely the solution of (2), while the original observability gramian corresponding to the solution of (3) is obtained by means of the

congruence transformation $\mathcal{Q} = \mathbf{E}_{ds}^* \hat{\mathcal{Q}} \mathbf{E}_{ds}$

The balancing and truncation procedures follow as described in Sect. 3.1, where (4) is replaced by: τ

$$U^*E_{ds}L = ZSY^*$$

The system representation in the new basis now becomes:

$$\begin{split} \mathbf{E}_{ds} &= \mathbf{W}^* \mathbf{E}_{ds} \mathbf{V} = \mathbf{I}_k, \mathbf{A}_{ds} = \mathbf{W}^* \mathbf{A}_{ds} \mathbf{V}, \\ \tilde{\mathbf{B}}_{ds} &= \mathbf{W}^* \mathbf{B}_{ds}, \tilde{\mathbf{C}}_{ds} = \mathbf{C}_{ds} \mathbf{V}, \tilde{\mathbf{D}}_{ds} = \mathbf{D}_{ds}. \end{split}$$

Gramians \mathcal{P} and \mathcal{Q} are simultaneously diagonalized as mentioned in Sect. 3.1.

Solving the Lyapunov equation

There are many methods for solving the Lyapunov equation $A\mathcal{P} + \mathcal{P}A^* = Q$ [1]. We will use the so-called square-root method, which directly computes U such that $\mathcal{P} = \mathbf{U}\mathbf{U}^*$. In MATLAB, this is implemented by lyapchol. Another important tool is the *sign function method*, which is discussed next.

The Lyapunov equation is a particular form of the Sylvester equation AX + XB = C. To treat this generalized case, consider a matrix of the type

$$\mathbf{Z} = \begin{pmatrix} \mathbf{A} & -\mathbf{C} \\ \mathbf{0} & -\mathbf{B} \end{pmatrix},$$

where $\mathbf{A} \in \mathbb{R}^{n \times n}$, $\Re(\lambda_i(\mathbf{A})) < 0$, $\mathbf{B} \in \mathbb{R}^{k \times k}$, $\Re(\lambda_i(\mathbf{B})) < 0$, and $\mathbf{C} \in \mathbb{R}^{n \times k}$. The sign function iteration $\mathbf{Z}_{n+1} = (\mathbf{Z}_n + \mathbf{Z}_n^{-1})/2$, $\mathbf{Z}_0 = \mathbf{Z}$ converges to

$$\lim_{j \to \infty} \mathbf{Z}_j = \begin{pmatrix} -\mathbf{I}_n & 2\mathbf{X} \\ \mathbf{0} & \mathbf{I}_k \end{pmatrix}$$

where X is the solution to the equation AX + XB = C.

For the Lyapunov equation $\mathbf{A}\mathcal{P} + \mathcal{P}\mathbf{A}^* = \mathbf{Q}$, the starting matrix is

³ As mentioned earlier, our analysis of the system in descriptor form is restricted to the case in which matrix $\mathbf{E}_{ds} = \mathbb{C}$ is invertible.

Roxana Ionutiu, Sanda Lefteriu, and Athanasios C. Antoulas

$$\mathbf{Z} = \begin{pmatrix} \mathbf{A} & -\mathbf{Q} \\ \mathbf{0} & -\mathbf{A}^* \end{pmatrix}, \ \mathbf{A} \in \mathbb{R}^{n \times n}, \ \Re(\lambda_i(\mathbf{A})) < 0 \Rightarrow \mathbf{Z}_j = \begin{pmatrix} \mathbf{A}_j & -\mathbf{Q}_j \\ \mathbf{0} & -\mathbf{A}_j^* \end{pmatrix}$$

where the iterations can be written as follows

8

 $\mathbf{A}_{j+1} = \frac{1}{2} \left(\mathbf{A}_j + \mathbf{A}_j^{-1} \right), \ \mathbf{A}_0 = \mathbf{A}; \ \mathbf{Q}_{j+1} = \frac{1}{2} \left(\mathbf{Q}_j + \mathbf{A}_j^{-1} \mathbf{Q}_j \mathbf{A}_j^{-*} \right), \ \mathbf{Q}_0 = \mathbf{Q}.$ The limits of these iterations are $\mathbf{A}_{\infty} = -\mathbf{I}_n$ and $\mathbf{Q}_{\infty} = 2\mathcal{P}$ where \mathcal{P} is the solution of the Lyapunov equation $\mathbf{A}\mathcal{P} + \mathcal{P}\mathbf{A}^* = \mathbf{Q}.$

Often, the constant term in the Lyapunov equation above is provided in factored form $\mathbf{Q} = \mathbf{R}\mathbf{R}^*$. As a consequence, it is possible to obtain the solution in factored form. In particular, the $(j + 1)^{st}$ iterate in factored form is

$$\mathbf{Q}_{j+1} = \mathbf{R}_{j+1}\mathbf{R}_{j+1}^*$$
 where $\mathbf{R}_{j+1} = \frac{1}{\sqrt{2}} \left[\mathbf{R}_j, \mathbf{A}_j^{-1}\mathbf{R}_j \right] \Rightarrow \mathbf{Q}_{\infty} = \mathbf{R}_{\infty}\mathbf{R}_{\infty}^* = 2\mathcal{P}$

 \mathbf{R}_{∞} has infinitely many columns, although its rank cannot exceed *n*. This can be avoided by performing at each step a rank revealing RQ factorization $\mathbf{R}_j \mathbf{P}_j = \mathbf{T}_j \mathbf{U}_j$ with \mathbf{P}_j the permutation matrix and $\mathbf{T}_j \mathbf{P}_j = [\Delta_j^*, \mathbf{0}]^*$. Δ_j is upper triangular and $\mathbf{U}_j \mathbf{U}_j^* = \mathbf{I}_j$. Thus, at the j^{th} step, \mathbf{R}_j is replaced by Δ_j which has as many columns as the rank of \mathbf{R}_j . For accelerating convergence, the eigenvalues of \mathbf{A} can be scaled [3]: at each step, \mathbf{A}_j is replaced by $\frac{1}{\gamma_j} \mathbf{A}_j$ where the factors γ_j can be chosen as $\gamma_j = |det(\mathbf{A}_j)|^{\frac{1}{n}}$ in order to minimize the distance of the geometric mean of the eigenvalues of \mathbf{A}_j from 1.

Convergence of the iteration which uses scaling is quadratic. The time required to compute the Cholesky factor by MATLAB's lyapchol function versus the iterative implementation of the sign function method in [3] is as follows: on a Pentium M at 1.3Ghz with 768MB RAM, lyapchol runs in 0.751s for a matrix A of dimension 242, while the implementation in [3] requires 5.423s and converges in $16 \approx \sqrt{242}$ steps. Even if, in theory, no scaling should also give quadratic convergence, in practice, due to numerical issues, convergence occurs after 20 steps.

3.2 Truncation by diagonalization of one gramian or poor man's truncated balanced reduction (PMTBR)

For the standard state-space representation, the procedure is the following [1].

- 1. Compute the gramian to be diagonalized (controllability gramian \mathcal{P} in our case)
- 2. Compute the eigenvalue decomposition of $\mathcal{P} = \mathbf{V} \Sigma \mathbf{V}^*$
- 3. Choose the eigenvectors corresponding to the largest k eigenvalues to obtain the transformation $\mathbf{T} = \mathbf{V}_k^*$
- 4. The reduced system is

$$\tilde{\mathbf{A}}_{ss} = \mathbf{T}\mathbf{A}_{ss}\mathbf{T}^*, \ \tilde{\mathbf{B}}_{ss} = \mathbf{T}\mathbf{B}_{ss}, \ \tilde{\mathbf{C}}_{ss} = \mathbf{C}_{ss}\mathbf{T}^*, \ \tilde{\mathbf{D}}_{ss} = \mathbf{D}_{ss}$$

PMTBR is presented in [10] and uses numerical quadrature to approximate the gramian \mathcal{P} , without solving the Lyapunov equation. The algorithm used in our analysis, however, diagonalizes the exact solution \mathcal{P} of the Lyapunov equation. As mentioned in Sect. 3.1, the solution to the Lyapunov equation can be computed either by using the *sign function method* or by using MATLAB's lyapchol function.

3.3 Positive real balanced truncation (PRBT)

Coupled transmission lines such as the one in Fig. 1 are passive systems, with *positive real* transfer functions (further information on passivity and positive realness is provided in [1]). We are therefore interested in reduced order models that are passive. In general, BT is not a passivity preserving method, since the resulting reduced system may have a non-positive real transfer function. PRBT, however, is a passivity preserving method. It yields reduced order models with positive real transfer functions by simultaneously diagonalizing the positive definite solutions \mathcal{P} and \mathcal{Q} of the controllability and observability algebraic *Riccati equations* respectively. This desirable result cannot be guaranteed with BT, where the solutions to the Lyapunov equations are diagonalized, rather than the solutions the Riccati equations. Riccati equations have a different form depending on whether the system is in standard state-space form or in descriptor form.

Historical note: this method was first introduced by Ober [6] and rediscovered by Phillips, Daniel and Silveira [9]. For an overview see also [1].

Standard state-space representation

The controllability and observability positive real Riccati equations are:

$$\mathbf{A}_{ss}\mathcal{P} + \mathcal{P}\mathbf{A}_{ss}^* + (\mathcal{P}\mathbf{C}_{ss}^* - \mathbf{B}_{ss})\Delta(\mathcal{P}\mathbf{C}_{ss}^* - \mathbf{B}_{ss})^* = 0$$
(7)

$$\mathbf{A}_{ss}^* \mathcal{Q} + \mathcal{Q} \mathbf{A}_{ss} + (\mathcal{Q} \mathbf{B}_{ss} - \mathbf{C}_{ss}^*) \Delta (\mathcal{Q} \mathbf{B}_{ss} - \mathbf{C}_{ss}^*)^* = 0$$
(8)

where $\Delta = (\mathbf{D}_{ss} + \mathbf{D}_{ss}^*)^{-1}$.

The procedure is the same as for BT (see Sect. 3.1), except that now balancing is performed on the minimal solutions of the Riccati equations. The diagonal elements of **S** in (4) are the *positive real singular values* of the system, which we denote by $\pi_i: \mathbf{S} = \text{diag}(\pi_1, \dots, \pi_n)$, where $\pi_1 \ge \pi_2 \ge \dots \ge \pi_n$.

Descriptor form representation

The corresponding algebraic Riccati equations in descriptor form are

$$\mathbf{A}_{ds}\mathcal{P}\mathbf{E}_{ds}^{*} + \mathbf{E}_{ds}\mathcal{P}\mathbf{A}_{ds}^{*} + (\mathbf{E}_{ds}\mathcal{P}\mathbf{C}_{ds}^{*} - \mathbf{B}_{ds})\Delta(\mathbf{E}_{ds}\mathcal{P}\mathbf{C}_{ds}^{*} - \mathbf{B}_{ds})^{*} = 0 \quad (9)$$

$$\mathbf{A}_{ds}^{*}\hat{\mathcal{Q}}\mathbf{E}_{ds} + \mathbf{E}_{ds}^{*}\hat{\mathcal{Q}}\mathbf{A}_{ds} + (\mathbf{E}_{ds}^{*}\hat{\mathcal{Q}}\mathbf{B}_{ds} - \mathbf{C}_{ds}^{*})\Delta(\mathbf{E}_{ds}^{*}\hat{\mathcal{Q}}\mathbf{B}_{ds} - \mathbf{C}_{ds}^{*})^{*} = 0 \quad (10)$$

where $\Delta = (\mathbf{D}_{ds} + \mathbf{D}_{ds}^*)^{-1}$. The observability gramian given by the solution of (8) is obtained via the congruence transformation $\mathcal{Q} = \mathbf{E}_{ds}^* \hat{\mathcal{Q}} \mathbf{E}_{ds}$.

Balancing and truncation are now performed on the solutions to (9) and (10) and the procedure follows as in 3.1.

Hamiltonian Riccati Balanced Truncation (PRBT-Ham)

Solutions to Riccati equations ((7),(8)) (or ((9),(10)) for MNA-similar form) can be obtained using the MATLAB function care. This can be applied to a system in usual state space form or in descriptor form. An alternative is to solve for \mathcal{P} and $\hat{\mathcal{Q}}$ by means of the Hamiltonian eigenvalue problem [11]:

$$\begin{bmatrix} \mathbf{A}_{ds} - \mathbf{B}_{ds} \Delta \mathbf{C}_{ds} & -\mathbf{B}_{ds} \Delta \mathbf{B}_{ds}^* \\ \mathbf{C}_{ds}^* \Delta \mathbf{C}_{ds} & -\mathbf{A}_{ds}^* + \mathbf{C}_{ds}^* \Delta \mathbf{B}_{ds}^* \end{bmatrix} \begin{bmatrix} \mathbf{X} \\ \mathbf{Y} \end{bmatrix} = \begin{bmatrix} \mathbf{E}_{ds} \\ \mathbf{E}_{ds}^* \end{bmatrix} \begin{bmatrix} \mathbf{X} \\ \mathbf{Y} \end{bmatrix} \begin{bmatrix} \boldsymbol{\Lambda}_{-} \\ \boldsymbol{\Lambda}_{+} \end{bmatrix}$$
(11)

10 Roxana Ionutiu, Sanda Lefteriu, and Athanasios C. Antoulas

where $\Delta = (\mathbf{D}_{ds} + \mathbf{D}_{ds}^*)^{-1}$, and Λ_- , Λ_+ are the Hamiltonian eigenvalues, with negative and positive real parts respectively (i.e. the *stable* and *antistable spectral zeros* of the system). We can partition **X** and **Y** according to the stable and antistable eigenvalues of the Hamiltonian into

$$\begin{bmatrix} \mathbf{X} \\ \mathbf{Y} \end{bmatrix} = \begin{bmatrix} \mathbf{X}_{-} & \mathbf{X}_{+} \\ \mathbf{Y}_{-} & \mathbf{Y}_{+} \end{bmatrix}$$

The minimal solutions to (9) and (10) are given by:

$$\mathcal{P} = -\mathbf{X}_{+}(\mathbf{Y}_{+})^{-1}\mathbf{E}_{ds}^{-*}$$
(12)

$$\hat{\mathcal{Q}} = -\mathbf{Y}_{-}(\mathbf{X}_{-})^{-1}\mathbf{E}_{ds}^{-1}$$
(13)

and are the same as the ones resulting from the MATLAB care routine. The stabilizing solution (corresponding to the stable spectral zeros) is \hat{Q} while \mathcal{P} is the antistabilizing solution (corresponding to the antistable spectral zeros). Both \hat{Q} and \mathcal{P} are obtained form the same Hamiltonian eigenvalue computation (11). The original positive real observability gramian as solution to (8) is $\mathcal{Q} = \mathbf{E}_{ds}^* \hat{\mathcal{Q}} \mathbf{E}_{ds}$, so the positive real Hankel singular values are $\pi_i = \sqrt{\lambda_i (\mathcal{P} \mathcal{Q})}$, i.e. the diagonal elements of $\mathbf{X}_+ (\mathbf{Y}_+)^{-1} \mathbf{Y}_- (\mathbf{X}_-)^{-1}$. We see that the positive real Hankel singular values can be computed without any inversion of \mathbf{E}_{ds} . The reduction procedure follows as in Sect. 3.1 using the computed (12) and (13).

If the system is the in usual state space form rather than in descriptor form, \mathbf{E}_{ds} in (11) is simply replaced by I. The resulting solutions \mathcal{P} and $\hat{\mathcal{Q}}$ computed as (12) and (13) respectively, are precisely the positive real gramians solving (7) and (8). They are also the same as the solutions obtained with the MATLAB care routine in the usual state space form. The reduction procedure follows as in Sect. 3.3.

NOTE: The gramians used in balanced truncation, i.e. the solutions to the Lyapunov equations ((2), (3)) (and correspondingly ((5), (6)) for descriptor form) can be obtained using (11) with $\Delta = I$, C = 0 (for controllability) and B = 0 (for observability).

4 Krylov based methods

Krylov based reduction methods exploit the use of Krylov subspace iterations to achieve system approximation by *moment matching* [1]. Three such methods are: PRIMA, the spectral zero method (SZM) and optimal \mathcal{H}_2 . As outlined next, PRIMA matches k moments at zero by means of an *orthogonal projection*. SZM matches 2k moments of the original system, at k stable spectral zeros and their mirror images (the corresponding k antistable spectral zeros), by means of an *oblique projection*. Finally, using an oblique projection, the optimal \mathcal{H}_2 method matches 2k moments of the original system at the mirror images of the k poles of the reduced system (2 moments are matched at each pole). Hence an iteration is required.

4.1 PRIMA

For PRIMA, the moments of the transfer function $\mathbf{H}(s) = \mathbf{L}(s\mathbb{C} - \mathbf{G})^{-1}\mathbf{B} + \mathbf{D}$ are defined as the coefficients of the Taylor expansion of $\mathbf{H}(s)$ around $s_0 = 0$: $\mathbf{H}(s) = \mathbf{M}_0 + \mathbf{M}_1 s + \mathbf{M}_2 s^2 + \dots$, where Comparison of Model Reduction Methods with Applications to Circuit Simulation

11

$$M_0 = D - LG^{-1}B$$
 and $M_k = (-1)^{(k+1)}L(\mathbb{C}^{-1}G)^{-(k+1)}\mathbb{C}^{-1}B$, for $k > 0$

PRIMA computes a k^{th} order reduced system by matching k moments of the original system. This is achieved by computing the orthogonal projection $\mathbf{\Pi} = \mathbf{X}_k \mathbf{X}_k^*$ such that $\mathbf{X}_k^* \mathbb{C}^{-1} \mathbf{G} \mathbf{X}_k = \mathbf{H}_k$ with \mathbf{H}_k upper Hessenberg; the *column span* of \mathbf{X}_k is the same as the *column span* of:

$$[\mathbb{C}^{-1}\mathbf{B}, \ (\mathbb{C}^{-1}\mathbf{G})^{-1}\mathbb{C}^{-1}\mathbf{B}, \ (\mathbb{C}^{-1}\mathbf{G})^{-2}\mathbb{C}^{-1}\mathbf{B}, \ \dots, \ (\mathbb{C}^{-1}\mathbf{G})^{-(k-1)}\mathbb{C}^{-1}\mathbf{B}].$$

The procedure is as follows [7].

- 1. Solve $\mathbf{GR} = \mathbf{B}$ for \mathbf{R} .
- 2. $(\mathbf{X}_0, \mathbf{T}) = QR(\mathbf{R}); QR$ Factorization of \mathbf{R}
- 3. For i = 1, 2, ..., kSet $\mathbf{V} = \mathbb{C}\mathbf{X}_{i-1}$ Solve $\mathbf{G}\mathbf{X}_{i}^{(0)} = \mathbf{V}$ for $\mathbf{X}_{i}^{(0)}$ For j = 1, 2, ..., i $\mathbf{H} = \mathbf{X}_{i-j}^* \mathbf{X}_{i}^{(j-1)}$ $\mathbf{X}_{i}^{(j)} = \mathbf{X}_{i}^{(j-1)} - \mathbf{X}_{i-j}\mathbf{H}$ $(\mathbf{X}_{i}, \mathbf{T}) = \mathbf{QR}(\mathbf{X}_{i}^{(i)})$; QR Factorization of $\mathbf{X}_{i}^{(i)}$
- 4. Set $\mathbf{X} = [\mathbf{X}_0 \ \mathbf{X}_1, \dots, \mathbf{X}_{i-1}]$ and truncate \mathbf{X} so that it has k columns only
- 5. Compute $\hat{\mathbb{C}} = \mathbf{X}^* \mathbb{C} \mathbf{X}$, $\hat{\mathbf{G}} = \mathbf{X}^* \mathbf{G} \mathbf{X}$, $\hat{\mathbf{B}} = \mathbf{X}^* \mathbf{B}$ and $\hat{\mathbf{L}} = \mathbf{L} \mathbf{X}$

4.2 Spectral zero method (SZM)

With PRIMA, system approximation was achieved by matching k moments of the transfer function at zero. In the general case, using the *rational Krylov* approach [1], reduced systems are obtained which match moments at preassigned *interpolation points* in the complex plane. SZM is a rational Krylov reduction method, in which the interpolation points are chosen as a subset of the spectral zeros of the original system [2], [11]. This selection guarantees the stability and passivity of the reduced system [2], [11]. The spectral zeros are given by Λ in (11). The real spectral zeros s_i come in pairs (s_i , $-s_i$) while the complex spectral zeros come in quadruples of the form:

$$\begin{aligned} s_i &= \Re(s_i) + j \cdot \Im(s_i), \\ s_{i+1} &= \Re(s_i) - j \cdot \Im(s_i) = s_i^*, \\ s_{i+2} &= -\Re(s_i) + j \cdot \Im(s_i) = -s_i^*, \\ s_{i+3} &= -\Re(s_i) - j \cdot \Im(s_i) = -s_i, \end{aligned}$$

where without loss of generality, we assume $\Re(s_i) < 0$.

The usual procedure

The usual procedure for obtaining a k^{th} order reduced system with SZM is as follows.

1. Construct matrices \mathbf{V} and \mathbf{W} using 2k interpolation points:

$$\mathbf{V} = \left[(s_1 \mathbf{E}_{ds} - \mathbf{A}_{ds})^{-1} \mathbf{B}_{ds}, (s_2 \mathbf{E}_{ds} - \mathbf{A}_{ds})^{-1} \mathbf{B}_{ds}, \cdots, (s_k \mathbf{E}_{ds} - \mathbf{A}_{ds})^{-1} \mathbf{B}_{ds} \right]$$